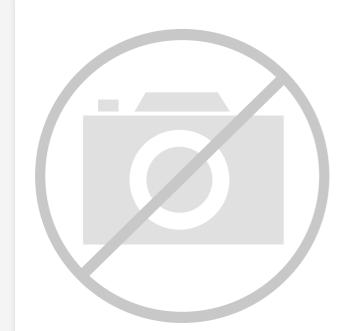
E·XFL



Welcome to E-XFL.COM

Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Details	
Product Status	Active
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	36864
Number of I/O	68
Number of Gates	250000
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	-55°C ~ 125°C (TJ)
Package / Case	100-TQFP
Supplier Device Package	100-VQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/a3p250-vq100m

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



Speed Grade and Temperature Grade Matrix

Temperature Grade	Std.	-1	-2 ¹
Μ	\checkmark	\checkmark	\checkmark
Notes: 1. M1 devices are not available in -2 s 2. M = Military temperature range: –55		ïe	

Contact your local Microsemi SoC Products Group (formerly Actel) representative for device availability: http://www.microsemi.com/contact/default.aspx. The CCC block has these key features:

- Wide input frequency range ($f_{IN CCC}$) = 1.5 MHz up to 250 MHz
- Output frequency range (f_{OUT CCC}) = 0.75 MHz up to 250 MHz
- 2 programmable delay types for clock skew minimization
- Clock frequency synthesis

Additional CCC specifications:

- Internal phase shift = 0°, 90°, 180°, and 270°. Output phase shift depends on the output divider configuration.
- Output duty cycle = 50% ± 1.5% or better
- Low output jitter: worst case < 2.5% × clock period peak-to-peak period jitter when single global network used
- Maximum acquisition time is 300 µs
- Exceptional tolerance to input period jitter—allowable input jitter is up to 1.5 ns
- Four precise phases; maximum misalignment between adjacent phases of 40 ps \times 250 MHz / $\rm ^{f}OUT$ ccc

Global Clocking

Military ProASIC3/EL devices have extensive support for multiple clocking domains. In addition to the CCC and PLL support described above, there is a comprehensive global clock distribution network.

Each VersaTile input and output port has access to nine VersaNets: six chip (main) and three quadrant global networks. The VersaNets can be driven by the CCC or directly accessed from the core via multiplexers (MUXes). The VersaNets can be used to distribute low-skew clock signals or for rapid distribution of high-fanout nets.

I/Os with Advanced I/O Standards

The military ProASIC3/EL family of FPGAs features a flexible I/O structure, supporting a range of voltages (1.5 V, 1.8 V, 2.5 V, and 3.3 V). In addition, 1.2 V I/O operation is supported for military ProASIC3EL devices. Military ProASIC3/EL FPGAs support different I/O standards, including single-ended, differential, and voltage-referenced (military ProASIC3EL). The I/Os are organized into banks, with two, four, or eight (military ProASIC3EL only) banks per device. The configuration of these banks determines the I/O standards supported. For military ProASIC3EL, each I/O bank is subdivided into V_{REF} minibanks, which are used by voltage-referenced I/Os. V_{REF} minibanks contain 8 to 18 I/Os. All the I/Os in a given minibank share a common V_{REF} line. Therefore, if any I/O in a given V_{REF} minibank is configured as a V_{REF} pin, the remaining I/Os in that minibank will be able to use that reference voltage.

Each I/O module contains several input, output, and enable registers. These registers allow the implementation of the following:

- Single-data-rate applications (e.g., PCI 66 MHz, bidirectional SSTL 2 and 3, Class I and II)
- Double-data-Rate applications (e.g., DDR LVDS, B-LVDS, and M-LVDS I/Os for point-to-point communications, and DDR 200 MHz SRAM using bidirectional HSTL Class II).

Military ProASIC3EL banks support LVPECL, LVDS, B-LVDS, and M-LVDS. B-LVDS and M-LVDS can support up to 20 loads.

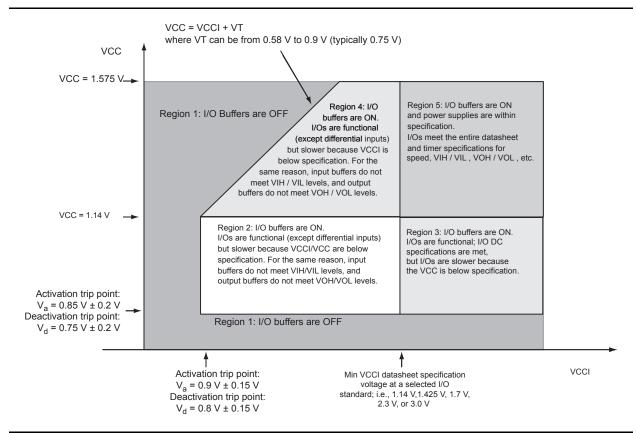


Figure 2-2 • Device Operating at 1.2 V Core Voltage – I/O State as a Function of VCCI and VCC Voltage Levels; Only A3PE600L and A3PE3000L Devices Operate at 1.2 V Core Voltage

Thermal Characteristics

Introduction

The temperature variable in the Designer software refers to the junction temperature, not the ambient temperature. This is an important distinction because dynamic and static power consumption cause the chip junction temperature to be higher than the ambient temperature.

EQ 1 can be used to calculate junction temperature.

 T_J = Junction Temperature = $\Delta T + T_A$

EQ 1

where:

T_A = Ambient Temperature

 ΔT = Temperature gradient between junction (silicon) and ambient ΔT = θ_{ia} * P

 θ_{ja} = Junction-to-ambient of the package. θ_{ja} numbers are located in Table 2-5.

P = Power dissipation

Package Thermal Characteristics

The device junction-to-case thermal resistivity is θ_{jc} and the junction-to-ambient air thermal resistivity is θ_{ja} . The thermal characteristics for θ_{ja} are shown for two air flow rates. The recommended maximum junction temperature is 125°C. EQ 2 shows a sample calculation of the recommended maximum power dissipation allowed for a 484-pin FBGA package at military temperature and in still air.

Maximum Power Allowed =
$$\frac{\text{Max. junction temp. (°C)} - \text{Max. ambient temp. (°C)}}{\theta_{ja}(°C/W)} = \frac{125°C - 70°C}{20.6°C/W} = 2.670$$

Calculating Power Dissipation Quiescent Supply Current

Table 2-8 • Power Supply State Per Mode

	Power Supply Configurations							
Modes/Power Supplies	VCC	VCCPLL	VCCI	VJTAG	VPUMP			
Flash*Freeze	On	On	On	On	On/off/floating			
Sleep	Off	Off	On	Off	Off			
Shutdown	Off	Off	Off	Off	Off			
Static and Active	On	On	On	On	On/off/floating			

Table 2-9 • Quiescent Supply Current (IDD) Characteristics, Flash*Freeze Mode*

	Core Voltage	A3PE600L	A3PE3000L	Units
Nominal (25°C)	1.2 V	0.55	2.75	mA
	1.5 V	0.83	4.2	mA
Typical maximum (25°C)	1.2 V	9	17	mA
	1.5 V	12	20	mA
Military maximum (125°C)	1.2 V	65	165	mA
	1.5 V	85	185	mA

Note: *IDD includes VCC, VPUMP, VCCI, VJTAG, and VCCPLL currents. Values do not include I/O static contribution (PDC6 and PDC7).

Table 2-10 • Quiescent Supply Current (IDD) Characteristics, Sleep Mode (VCC = 0 V)*

	Core Voltage	A3PE600L	A3PE3000L	Units
VCCI / VJTAG = 1.2 V (per bank) Typical (25°C)	1.2 V	1.7	1.7	μΑ
VCCI / VJTAG = 1.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.8	1.8	μΑ
VCCI / VJTAG = 1.8 V (per bank) Typical (25°C)	1.2 V / 1.5 V	1.9	1.9	μΑ
VCCI / VJTAG = 2.5 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.2	2.2	μΑ
VCCI / VJTAG = 3.3 V (per bank) Typical (25°C)	1.2 V / 1.5 V	2.5	2.5	μA

Note: *IDD = N_{BANKS} × ICCI. Values do not include I/O static contribution, which is shown in Table 2-22 on page 2-14 (PDC6 and PDC7).

Table 2-11 • Quiescent Supply Current (IDD) Characteristics, Shutdown Mode*

	Core Voltage	A3P250	A3P1000	A3PE600L	A3PE3000L	Units
Nominal (25°C)	1.2 V / 1.5 V	N//	4		0	μA
Military (125°C)	1.2 V / 1.5 V	N//	4		0	μA

Note: *This is applicable to A3PE600L and A3PE3000L only for cold-sparable I/O devices. Not available on A3P250 or A3P1000.

 Table 2-17 •
 Summary of I/O Output Buffer Power (per pin) – Default I/O Software Settings ¹

 Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

	C _{LOAD} (pF)	VCCI (V)	Static Power PDC7 (mW) ²	Dynamic Power PAC10 (µW/MHz) ³
Single-Ended				
3.3 V LVTTL/LVCMOS	5	3.3	_	148.00
3.3 V LVCMOS Wide Range	5	3.3	-	148.00
2.5 V LVCMOS	5	2.5	-	83.23
1.8 V LVCMOS	5	1.8	-	54.58
1.5 V LVCMOS (JESD8-11)	5	1.5	-	37.05
1.2 V LVCMOS	5	1.2	_	17.94
1.2 V LVCMOS Wide Range	5	1.2	-	17.94
3.3 V PCI	10	3.3	-	204.61
3.3 V PCI-X	10	3.3	_	204.61
Voltage-Referenced				
3.3 V GTL	10	3.3	-	24.08
2.5 V GTL	10	2.5	_	13.52
3.3 V GTL+	10	3.3	_	24.10
2.5 V GTL+	10	2.5	-	13.54
HSTL (I)	20	1.5	7.08	26.22
HSTL (II)	20	1.5	13.88	27.18
SSTL2 (I)	30	2.5	16.69	105.56
SSTL2 (II)	30	2.5	25.91	116.48
SSTL3 (I)	30	3.3	26.02	114.67
SSTL3 (II)	30	3.3	42.21	131.69
Differential			•	•
LVDS	-	2.5	7.70	89.58
LVPECL	_	3.3	19.42	167.86

Notes:

1. Dynamic power consumption is given for standard load and software default drive strength and output slew.

2. PDC7 is the static power (where applicable) measured on VCCI.

3. PAC10 is the total dynamic power measured on VCCI.

Microsemi. Military ProASIC3/EL DC and Switching Characteristics

For example, at 110°C, the short current condition would have to be sustained for more than three months to cause a reliability concern. The I/O design does not contain any short circuit protection, but such protection would only be needed in extremely prolonged stress conditions.

Table 2-44 • Duration of Short Circuit Event before Failure

Temperature	Time before Failure
–50°C	> 20 years
-40°C	> 20 years
0°C	> 20 years
25°C	> 20 years
70°C	5 years
85°C	2 years
100°C	6 months
110°C	3 months
125°C	1 month

Table 2-45 • I/O Input Rise Time, Fall Time, and Related I/O Reliability

Input Buffer	Input Rise/Fall Time (min.)	Input Rise/Fall Time (max.)	Reliability
LVTTL/LVCMOS	No requirement	10 ns *	20 years (110°C)
LVDS/B-LVDS/ M-LVDS/LVPECL	No requirement	10 ns *	10 years (100°C)

Note: *The maximum input rise/fall time is related to the noise induced in the input buffer trace. If the noise is low, the rise time and fall time of input buffers can be increased beyond the maximum value. The longer the rise/fall times, the more susceptible the input signal is to the board noise. Microsemi recommends signal integrity evaluation/characterization of the system to ensure that there is no excessive noise coupling into input signals.

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Military ProASIC3/EL DC and Switching Characteristics

Default		IL	v	IH	VOL	VOH	IOL	юн	IOSL	IOSH	IIL ²	IIH ³
Drive Strength Option ¹	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	μA	μA	Max. mA ⁴	Max. mA ⁴	μ Α 5	μ Α 5
2 mA	-0.3	0.8	2	3.6	0.2	VCCI – 0.2	100	100	25	27	15	15
4 mA	-0.3	0.8	2	3.6	0.2	VCCI – 0.2	100	100	25	27	15	15
6 mA	-0.3	0.8	2	3.6	0.2	VCCI – 0.2	100	100	51	54	15	15
8 mA	-0.3	0.8	2	3.6	0.2	VCCI – 0.2	100	100	51	54	15	15
12 mA	-0.3	0.8	2	3.6	0.2	VCCI – 0.2	100	100	103	109	15	15
16 mA	-0.3	0.8	2	3.6	0.2	VCCI – 0.2	100	100	132	127	15	15
	Software Default Drive Strength Option ¹ 2 mA 4 mA 6 mA 8 mA 12 mA	Software Default Drive Strength Option ¹ V 2 mA -0.3 4 mA -0.3 6 mA -0.3 8 mA -0.3 12 mA -0.3	Software Default Drive Strength Option ¹ VIL Min. Option ¹ Max. V 2 mA -0.3 0.8 4 mA -0.3 0.8 6 mA -0.3 0.8 8 mA -0.3 0.8 12 mA -0.3 0.8	Software Default Drive Strength Option ¹ VIL V Min. Option ¹ Max. V Min. V Max. V Min. V 2 mA -0.3 0.8 2 4 mA -0.3 0.8 2 6 mA -0.3 0.8 2 8 mA -0.3 0.8 2 12 mA -0.3 0.8 2	Software Default Drive Strength Option ¹ VIL VIH Min. Option ¹ Min. V Min. V Min. V Max. V Max. V <td< td=""><td>Software Default Drive Strength Option¹ VIL VIH VOL Min. Option¹ Min. V Max. V Min. V Max. V Ma</td><td>Software Default Drive Strength Option¹ VIL VIH VOL VOH Min. Option¹ Max. V Min. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Min. V 2 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 4 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 6 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 8 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 12 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2</td><td>Software Default Drive Strength Option¹ VIL VIH VOL VOH IOL Min. Option¹ Max. V Max. V Max. V Max. V Max. V Max. V Max. V Min. V Min. V Max. V Max. V Max. V Min. V Min. V Max. V Min. V Max. V Min. V Min. V Max. V Min. V Min. V Max. V Min. V Min. V<</td><td>Software Default Drive Strength Option¹ VIL VOL VOH IOL IOH Min. Option¹ Max. V Max. V Max. V Max. V Max. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Min. V Max. V Min. V Max. V Min. V Max. V Max. V Max. V Min. V Max. V Max. V<</td><td>Software Default Drive Strength Option¹ VIL VIH VOL VOH IOL IOH IOSL Min. Option¹ Min. V Max. V Max. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V</td><td>Software Default Drive Strength Option¹ VIL VIH VOL VOH IOL IOH IOSL IOSH Min. Option¹ Min. V Max. V Max. V Max. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V</td><td>Software Default Drive Strength Option¹ VIL VIH VOL VOH IOL IOH IOSL IOSH IIL² Min. Option¹ Min. V Max. V Min. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Max. MA4 Max. MA4</td></td<>	Software Default Drive Strength Option ¹ VIL VIH VOL Min. Option ¹ Min. V Max. V Min. V Max. V Ma	Software Default Drive Strength Option ¹ VIL VIH VOL VOH Min. Option ¹ Max. V Min. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Min. V 2 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 4 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 6 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 8 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2 12 mA -0.3 0.8 2 3.6 0.2 VCCI - 0.2	Software Default Drive Strength Option ¹ VIL VIH VOL VOH IOL Min. Option ¹ Max. V Max. V Max. V Max. V Max. V Max. V Max. V Min. V Min. V Max. V Max. V Max. V Min. V Min. V Max. V Min. V Max. V Min. V Min. V Max. V Min. V Min. V Max. V Min. V Min. V<	Software Default Drive Strength Option ¹ VIL VOL VOH IOL IOH Min. Option ¹ Max. V Max. V Max. V Max. V Max. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Min. V Max. V Min. V Max. V Min. V Max. V Max. V Max. V Min. V Max. V Max. V<	Software Default Drive Strength Option ¹ VIL VIH VOL VOH IOL IOH IOSL Min. Option ¹ Min. V Max. V Max. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V	Software Default Drive Strength Option ¹ VIL VIH VOL VOH IOL IOH IOSL IOSH Min. Option ¹ Min. V Max. V Max. V Max. V Max. V Min. V Max. V Max. V Min. V Max. V Max. V	Software Default Drive Strength Option ¹ VIL VIH VOL VOH IOL IOH IOSL IOSH IIL ² Min. Option ¹ Min. V Max. V Min. V Max. V Max. V Min. V Max. V Min. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Max. V Max. MA4 Max. MA4

Table 2-60 • Minimum and Maximum DC Input and Output Levels Applicable to Standard Plus I/O Banks

Notes:

1. Note that 3.3 V LVCMOS wide range is applicable to 100 μA drive strength only. The configuration will not operate at the equivalent software default drive strength. These values are for normal ranges only.

2. I_{IL} is the input leakage current per I/O pin over recommended operation conditions where –0.3 V < VIN < VIL.

3. I_{IH} is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges

4. Currents are measured at 125°C junction temperature.

5. All LVMCOS 3.3 V software macros support LVCMOS 3.3 V wide range as specified in the JESD8-A specification.

6. Software default selection highlighted in gray.

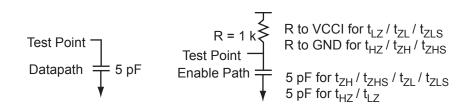


Figure 2-8 • AC Loading

Table 2-61 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	VREF (Typ) (V)	C _{LOAD} (pF)
0	3.3	1.4	_	5

Note: *Measuring point = $V_{trip.}$ See Table 2-29 on page 2-25 for a complete table of trip points.

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Military ProASIC3/EL DC and Switching Characteristics

Table 2-84 • Minimum and Maximum DC Input and Output Levels Applicable to Standard Plus I/O I/O Banks

1.8 V LVCMOS	VIL		VIH		VOL	VOH	I _{OL}	I _{OH}	I _{OSL}	I _{OSH}	I _{IL} 1	I _{IH} 2
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA ³	Max. mA ³	μA ⁴	μA ⁴
2 mA	-0.3	0.35 * VCCI	0.65 * VCCI	1.9	0.45	VCCI - 0.45	2	2	9	11	15	15
4 mA	-0.3	0.35 * VCCI	0.65 * VCCI	1.9	0.45	VCCI - 0.45	4	4	17	22	15	15
6 mA	-0.3	0.35 * VCCI	0.65 * VCCI	1.9	0.45	VCCI - 0.45	6	6	35	44	15	15
8 mA	-0.3	0.35 * VCCI	0.65 * VCCI	1.9	0.45	VCCI - 0.45	8	8	35	44	15	15

Notes:

1. I_{IL} is the input leakage current per I/O pin over recommended operation conditions where -0.3 V < VIN < VIL.

2. I_{IH} is the input leakage current per I/O pin over recommended operating conditions VIH < VIN < VCCI. Input current is larger when operating outside recommended ranges

3. Currents are measured at 100°C junction temperature and maximum voltage.

4. Currents are measured at 125°C junction temperature.

5. Software default selection highlighted in gray.

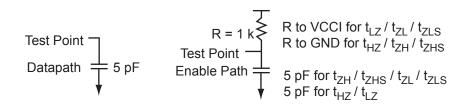


Figure 2-10 • AC Loading

Table 2-85 • AC Waveforms, Measuring Points, and Capacitive Loads

Input Low (V)	Input High (V)	Measuring Point* (V)	VREF (Typ) (V)	C _{LOAD} (pF)
0	1.8	0.9	_	5

Note: *Measuring point = V_{trip} . See Table 2-29 on page 2-25 for a complete table of trip points.



Table 2-180 • Output Enable Register Propagation DelaysMilitary-Case Conditions: TJ = 125°C, Worst-Case VCC = 1.425 V for A3P250 and A3P1000

Parameter	Description	-1	Std.	Units
t _{OECLKQ}	Clock-to-Q of the Output Enable Register		0.63	ns
t _{OESUD}	Data Setup Time for the Output Enable Register	0.38	0.44	ns
t _{OEHD}	Data Hold Time for the Output Enable Register	0.00	0.00	ns
t _{OESUE}	Enable Setup Time for the Output Enable Register	0.52	0.62	ns
t _{OEHE}	Enable Hold Time for the Output Enable Register	0.00	0.00	ns
t _{OECLR2Q}	Asynchronous Clear-to-Q of the Output Enable Register	0.80	0.94	ns
t _{OEPRE2Q}	Asynchronous Preset-to-Q of the Output Enable Register	0.80	0.94	ns
t _{OEREMCLR}	Asynchronous Clear Removal Time for the Output Enable Register	0.00	0.00	ns
tOERECCLR	Asynchronous Clear Recovery Time for the Output Enable Register	0.27	0.31	ns
t _{OEREMPRE}	Asynchronous Preset Removal Time for the Output Enable Register	0.00	0.00	ns
t _{OERECPRE}	Asynchronous Preset Recovery Time for the Output Enable Register	0.27	0.31	ns
t _{OEWCLR}	Asynchronous Clear Minimum Pulse Width for the Output Enable Register	0.25	0.30	ns
t _{OEWPRE}	Asynchronous Preset Minimum Pulse Width for the Output Enable Register	0.25	0.30	ns
t _{OECKMPWH}	Clock Minimum Pulse Width HIGH for the Output Enable Register	0.41	0.48	ns
t _{OECKMPWL}	Clock Minimum Pulse Width LOW for the Output Enable Register	0.37	0.43	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

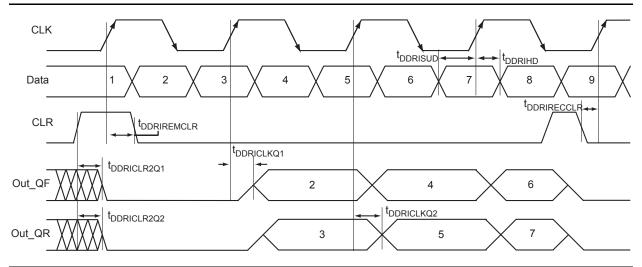


Figure 2-34 • Input DDR Timing Diagram

Timing Characteristics

Table 2-182 • Input DDR Propagation DelaysMilitary-Case Conditions: TJ = 125°C, Worst-Case VCC = 1.14 V for A3PE600L and A3PE3000L

Parameter	Description	-1	Std.	Units
t _{DDRICLKQ1}	Clock-to-Out Out_QR for Input DDR	0.38	0.45	ns
t _{DDRICLKQ2}	Clock-to-Out Out_QF for Input DDR	0.54	0.63	ns
t _{DDRISUD1}	Data Setup for Input DDR (fall)	0.39	0.46	ns
t _{DDRISUD2}	Data Setup for Input DDR (rise)	0.34	0.40	ns
t _{DDRIHD1}	Data Hold for Input DDR (fall)	0.00	0.00	ns
t _{DDRIHD2}	Data Hold for Input DDR (rise)	0.00	0.00	ns
t _{DDRICLR2Q1}	Asynchronous Clear-to-Out Out_QR for Input DDR	0.64	0.75	ns
t _{DDRICLR2Q2}	Asynchronous Clear-to-Out Out_QF for Input DDR	0.79	0.93	ns
t _{DDRIREMCLR}	Asynchronous Clear Removal Time for Input DDR	0.00	0.00	ns
t _{DDRIRECCLR}	Asynchronous Clear Recovery Time for Input DDR		0.36	ns
t _{DDRIWCLR}	Asynchronous Clear Minimum Pulse Width for Input DDR		0.22	ns
t _{DDRICKMPWH}	Clock Minimum Pulse Width HIGH for Input DDR		0.36	ns
t _{DDRICKMPWL}	Clock Minimum Pulse Width LOW for Input DDR	0.28	0.32	ns
F _{DDRIMAX}	Maximum Frequency for Input DDR	160	160	MHz

Note: For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

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Military ProASIC3/EL DC and Switching Characteristics

Table 2-194 • Register Delays

Parameter	Description	-1	Std.	Units
t _{CLKQ}	Clock-to-Q of the Core Register	0.66	0.78	ns
t _{SUD}	Data Setup Time for the Core Register	0.52	0.61	ns
t _{HD}	Data Hold Time for the Core Register	0.00	0.00	ns
t _{SUE}	Enable Setup Time for the Core Register	0.55	0.64	ns
t _{HE}	Enable Hold Time for the Core Register	0.00	0.00	ns
t _{CLR2Q}	Asynchronous Clear-to-Q of the Core Register	0.48	0.56	ns
t _{PRE2Q}	Asynchronous Preset-to-Q of the Core Register	0.48	0.56	ns
t _{REMCLR}	Asynchronous Clear Removal Time for the Core Register	0.00	0.00	ns
t _{RECCLR}	Asynchronous Clear Recovery Time for the Core Register	0.27	0.31	ns
t _{REMPRE}	Asynchronous Preset Removal Time for the Core Register	0.00	0.00	ns
t _{RECPRE}	Asynchronous Preset Recovery Time for the Core Register	0.27	0.31	ns
t _{WCLR}	Asynchronous Clear Minimum Pulse Width for the Core Register	0.25	0.30	ns
t _{WPRE}	Asynchronous Preset Minimum Pulse Width for the Core Register	0.25	0.30	ns
t _{CKMPWH}	Clock Minimum Pulse Width HIGH for the Core Register	0.41	0.48	ns
t _{CKMPWL}	Clock Minimum Pulse Width LOW for the Core Register	0.37	0.43	ns

Note: For specific junction temperature and voltage supply levels, refer to Table 2-7 on page 2-6 for derating values.

Global Resource Characteristics

A3P1000 Clock Tree Topology

Clock delays are device-specific. Figure 2-41 is an example of a global tree used for clock routing. The global tree presented in Figure 2-41 is driven by a CCC located on the west side of the A3P1000 device. It is used to drive all D-flip-flops in the device.

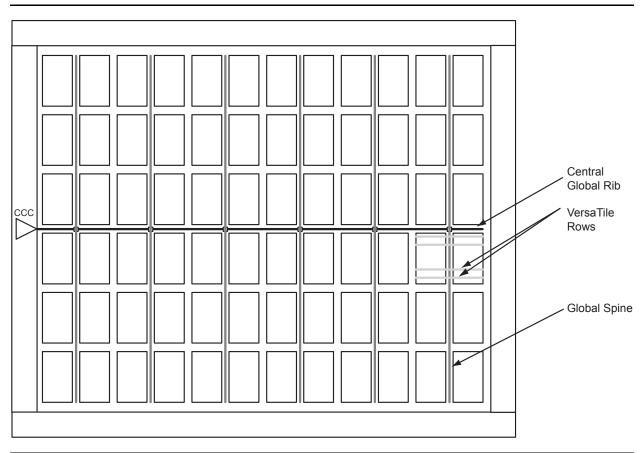
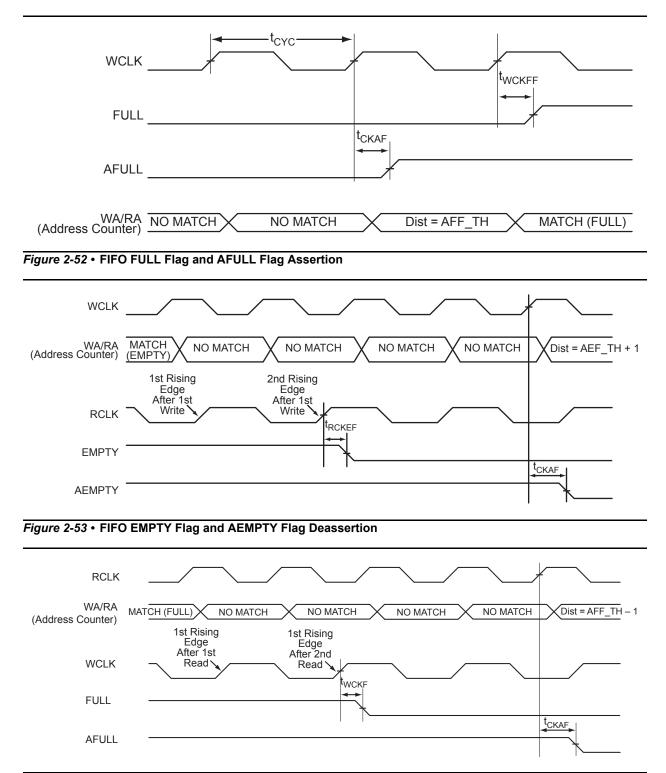
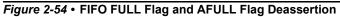


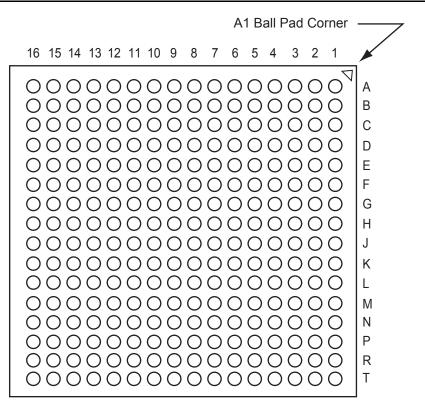
Figure 2-41 • Example of Global Tree Use in an A3P1000 Device for Clock Routing

Military ProASIC3/EL Low Power Flash FPGAs









Note: This is the bottom view of the package.

Note

For Package Manufacturing and Environmental information, visit the Resource Center at http://www.microsemi.com/products/fpga-soc/solutions.



Package Pin Assignments

FG484			FG484		FG484
Pin Number	A3P1000 Function	Pin Number	A3P1000 Function	Pin Number	A3P1000 Function
R8	VMV3	T21	IO108PDB1	V12	IO143RSB2
R9	VCCIB2	T22	IO105NDB1	V13	IO138RSB2
R10	VCCIB2	U1	IO195PDB3	V14	IO131RSB2
R11	IO147RSB2	U2	IO195NDB3	V15	IO125RSB2
R12	IO136RSB2	U3	IO194NPB3	V16	GDB2/IO115RSB2
R13	VCCIB2	U4	GEB1/IO189PDB3	V17	TDI
R14	VCCIB2	U5	GEB0/IO189NDB3	V18	GNDQ
R15	VMV2	U6	VMV2	V19	TDO
R16	IO110NDB1	U7	IO179RSB2	V20	GND
R17	GDB1/IO112PPB1	U8	IO171RSB2	V21	NC
R18	GDC1/IO111PDB1	U9	IO165RSB2	V22	IO109NDB1
R19	IO107NDB1	U10	IO159RSB2	W1	NC
R20	VCC	U11	IO151RSB2	W2	IO191PDB3
R21	IO104NDB1	U12	IO137RSB2	W3	NC
R22	IO105PDB1	U13	IO134RSB2	W4	GND
T1	IO198PDB3	U14	IO128RSB2	W5	IO183RSB2
T2	IO198NDB3	U15	VMV1	W6	GEB2/IO186RSB2
Т3	NC	U16	ТСК	W7	IO172RSB2
T4	IO194PPB3	U17	VPUMP	W8	IO170RSB2
T5	IO192PPB3	U18	TRST	W9	IO164RSB2
T6	GEC1/IO190PPB3	U19	GDA0/IO113NDB1	W10	IO158RSB2
T7	IO192NPB3	U20	NC	W11	IO153RSB2
T8	GNDQ	U21	IO108NDB1	W12	IO142RSB2
Т9	GEA2/IO187RSB2	U22	IO109PDB1	W13	IO135RSB2
T10	IO161RSB2	V1	NC	W14	IO130RSB2
T11	IO155RSB2	V2	NC	W15	GDC2/IO116RSB2
T12	IO141RSB2	V3	GND	W16	IO120RSB2
T13	IO129RSB2	V4	GEA1/IO188PDB3	W17	GDA2/IO114RSB2
T14	IO124RSB2	V5	GEA0/IO188NDB3	W18	TMS
T15	GNDQ	V6	IO184RSB2	W19	GND
T16	IO110PDB1	V7	GEC2/IO185RSB2	W20	NC
T17	VJTAG	V8	IO168RSB2	W21	NC
T18	GDC0/IO111NDB1	V9	IO163RSB2	W22	NC
T19	GDA1/IO113PDB1	V10	IO157RSB2	Y1	VCCIB3
T20	NC	V11	IO149RSB2	Y2	IO191NDB3



FG896				
Pin Number A3PE3000L Function				
N20	VCC			
N21	VCCIB2			
N22	IO106NDB2V3			
N23	IO106PDB2V3			
N24	IO108PDB2V3			
N25	IO108NDB2V3			
N26	IO95NDB2V1			
N27	IO99NDB2V2			
N28	IO99PDB2V2			
N29	IO107PDB2V3			
N30	IO107NDB2V3			
P1	IO276NDB7V0			
P2	IO278NDB7V0			
P3	IO280NDB7V0			
P4	IO284NDB7V1			
P5	IO279NDB7V0			
P6	GFC1/IO275PDB7V0			
P7	GFC0/IO275NDB7V0			
P8	IO277PDB7V0			
P9	IO277NDB7V0			
P10	VCCIB7			
P11	VCC			
P12	GND			
P13	GND			
P14	GND			
P15	GND			
P16	GND			
P17	GND			
P18	GND			
P19	GND			
P20	VCC			
P21	VCCIB2			
P22	GCC1/IO112PDB2V3			
P23	IO110PDB2V3			
P24	IO110NDB2V3			
P25	IO109PPB2V3			